

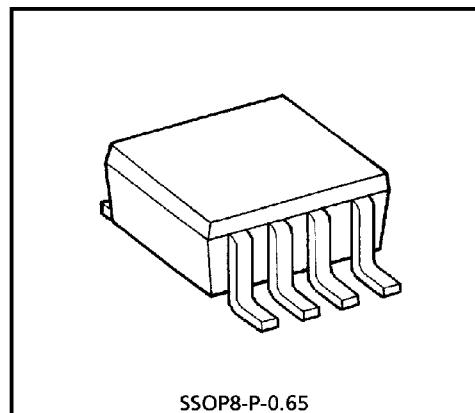
TOSHIBA CMOS LINEAR INTEGRATED CIRCUIT SILICON MONOLITHIC

**TC75W54FU****DUAL OPERATIONAL AMPLIFIER**

TC75W54FU is a CMOS operational amplifier with low supply voltage, low supply current.

**FEATURES**

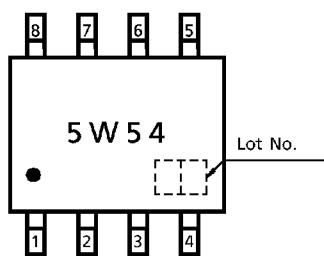
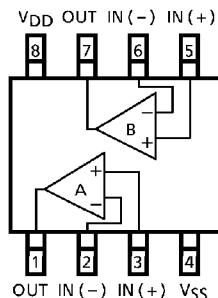
- Low supply voltage :  $V_{DD} = \pm 0.9\sim 3.5V$  or  $1.8\sim 7V$
- Low supply current :  $I_{DD} (V_{DD} = 3V) = 200\mu A$  (Typ.)
- The internally phase compensated operational amplifier.
- Small package



Weight : 0.021g (Typ.)

**MAXIMUM RATINGS ( $T_a = 25^\circ C$ )**

CHARACTERISTIC	SYMBOL	RATING	UNIT
Supply Voltage	$V_{DD}, V_{SS}$	7	V
Differential Input Voltage	$DV_{IN}$	$\pm 7$	V
Input Voltage	$V_{IN}$	$V_{DD}\sim V_{SS}$	V
Power Dissipation	$P_D$	250	mW
Operating Temperature	$T_{opr}$	$-40\sim 85$	$^\circ C$
Storage Temperature	$T_{stg}$	$-55\sim 125$	$^\circ C$

**MARKING (TOP VIEW)****PIN CONNECTION (TOP VIEW)**

961001EBA2

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**ELECTRICAL CHARACTERISTICS**DC CHARACTERISTICS ( $V_{DD} = 3.0V$ ,  $V_{SS} = GND$ ,  $T_a = 25^\circ C$ )

CHARACTERISTIC	SYMBOL	TEST CIR-CUIT	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Input Offset Voltage	$V_{IO}$	1	$R_S = 1k\Omega$	—	2	10	mV
Input Offset Current	$I_{IO}$	—	—	—	1	—	pA
Input Bias Current	$I_I$	—	—	—	1	—	pA
Common Mode Input Voltage	$CMV_{IN}$	2	—	0.0	—	2.1	V
Voltage Gain (Open Loop)	$G_V$	—	—	60	70	—	dB
Maximum Output Voltage	$V_{OH}$	3	$R_L \geq 100k\Omega$	2.9	—	—	V
	$V_{OL}$	4	$R_L \geq 100k\Omega$	—	—	0.1	
Common Mode Input Signal Rejection Ratio	$CMRR$	2	$V_{IN} = 0.0 \sim 2.1V$	60	70	—	dB
Supply Voltage Rejection Ratio	$SVRR$	1	$V_{DD} = 1.8 \sim 7.0V$	60	70	—	dB
Supply Current	$I_{DD}$	5	—	—	200	400	$\mu A$
Source Current	$I_{source}$	6	—	100	200	—	$\mu A$
Sink Current	$I_{sink}$	7	—	200	700	—	$\mu A$

DC CHARACTERISTICS ( $V_{DD} = 1.8V$ ,  $V_{SS} = GND$ ,  $T_a = 25^\circ C$ )

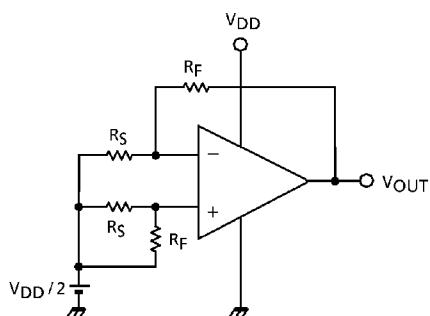
CHARACTERISTIC	SYMBOL	TEST CIR-CUIT	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Input Offset Voltage	$V_{IO}$	1	$R_S = 10k\Omega$	—	2	10	mV
Input Offset Current	$I_{IO}$	—	—	—	1	—	pA
Input Bias Current	$I_I$	—	—	—	1	—	pA
Common Mode Input Voltage	$CMV_{IN}$	2	—	0.2	—	0.9	V
Voltage Gain (Open Loop)	$G_V$	—	—	60	70	—	dB
Maximum Output Voltage	$V_{OH}$	3	$R_L \geq 100k\Omega$	1.7	—	—	V
	$V_{OL}$	4	$R_L \geq 100k\Omega$	—	—	0.1	
Supply Current	$I_{DD}$	5	—	—	160	320	$\mu A$
Source Current	$I_{source}$	6	—	80	160	—	$\mu A$
Sink Current	$I_{sink}$	7	—	200	600	—	$\mu A$

AC CHARACTERISTICS ( $V_{DD} = 3.0V$ ,  $V_{SS} = GND$ ,  $T_a = 25^\circ C$ )

CHARACTERISTIC	SYMBOL	TEST CIR-CUIT	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Slew Rate	$SR$	—	—	—	0.7	—	$V/\mu s$
Unity Gain Cross Frequency	$f_T$	—	—	—	0.9	—	MHz

AC CHARACTERISTICS ( $V_{DD} = 1.8V$ ,  $V_{SS} = GND$ ,  $T_a = 25^\circ C$ )

CHARACTERISTIC	SYMBOL	TEST CIR-CUIT	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Slew Rate	$SR$	—	—	—	0.6	—	$V/\mu s$
Unity Gain Cross Frequency	$f_T$	—	—	—	0.8	—	MHz

**TEST CIRCUIT****1. SVRR,  $V_{IO}$** 

- **SVRR**

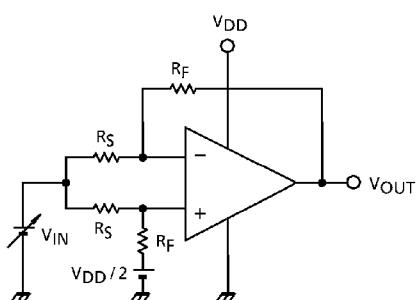
$V_{DD} = 1.8V : V_{DD} = V_{DD1}, V_{OUT} = V_{OUT1}$

$V_{DD} = 7.0V : V_{DD} = V_{DD2}, V_{OUT} = V_{OUT2}$

$$SVRR = 20\log\left(\left|\frac{V_{OUT1} - V_{OUT2}}{V_{DD1} - V_{DD2}}\right| \times \frac{R_S}{R_F + R_S}\right)$$

- $V_{IO}$

$$V_{IO} = \left(V_{OUT} - \frac{V_{DD}}{2}\right) \times \frac{R_S}{R_F + R_S}$$

**2. CMRR,  $CMV_{IN}$** 

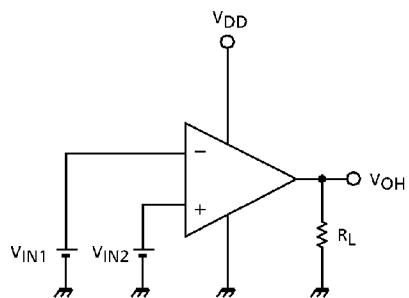
- **CMRR**

$V_{IN} = 0.0V : V_{IN} = V_{IN1}, V_{OUT} = V_{OUT1}$

$V_{IN} = 2.1V : V_{IN} = V_{IN2}, V_{OUT} = V_{OUT2}$

$$CMRR = 20\log\left(\left|\frac{V_{OUT1} - V_{OUT2}}{V_{IN1} - V_{IN2}}\right| \times \frac{R_S}{R_F + R_S}\right)$$

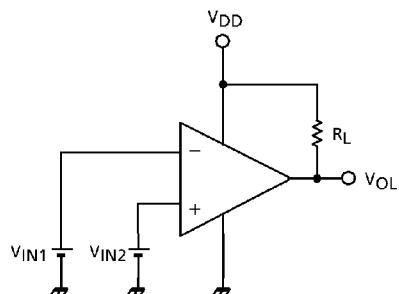
- **$CMV_{IN}$**

**3.  $V_{OH}$** 

- **$V_{OH}$**

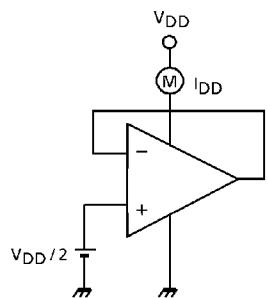
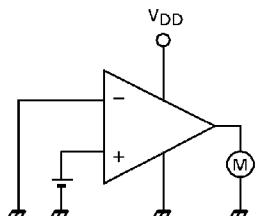
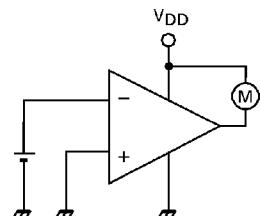
$$V_{IN1} = \frac{V_{DD}}{2} - 0.05V$$

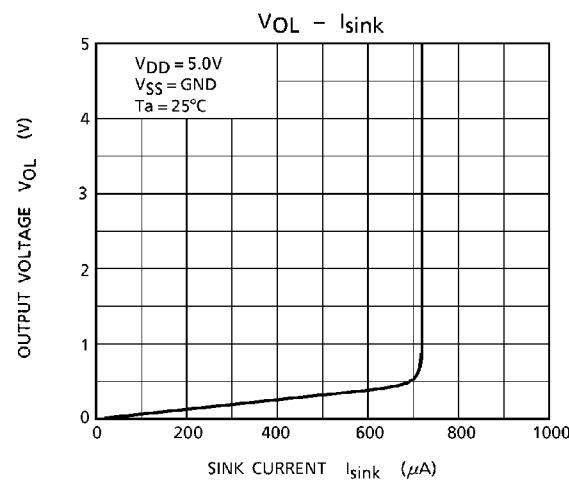
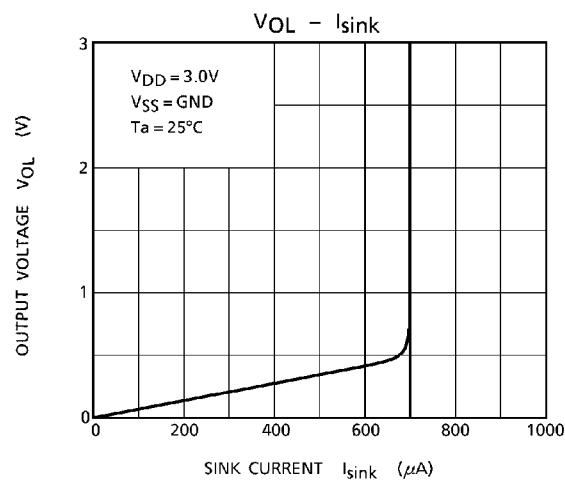
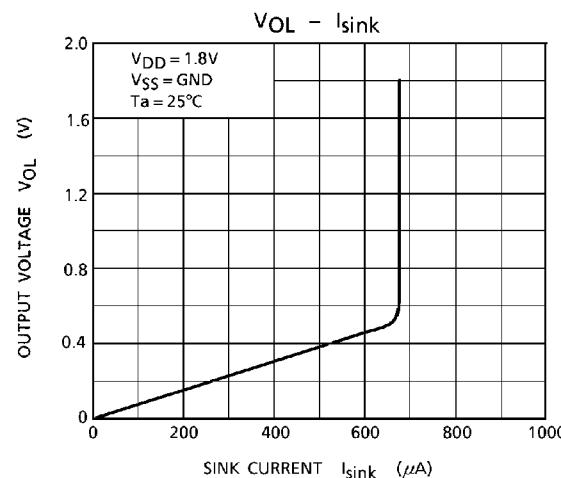
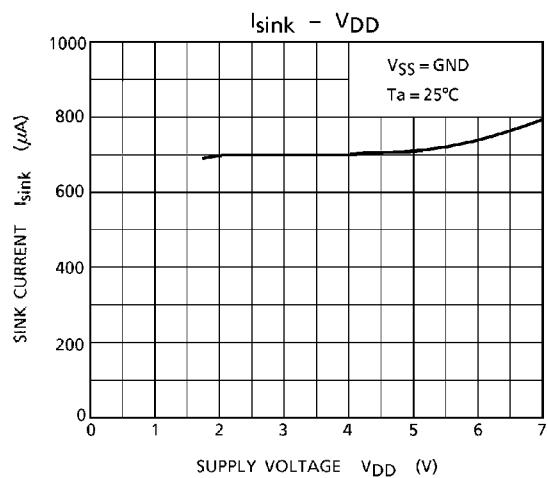
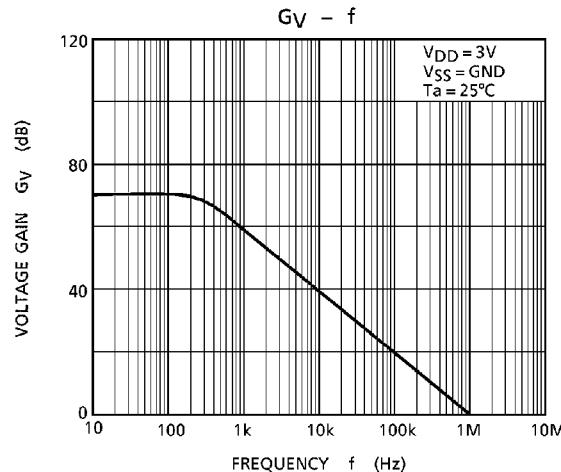
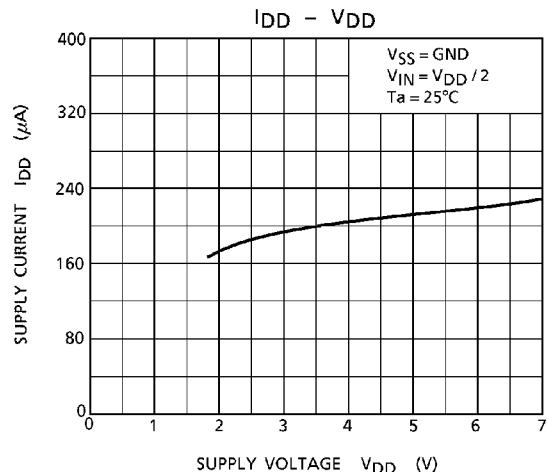
$$V_{IN2} = \frac{V_{DD}}{2} + 0.05V$$

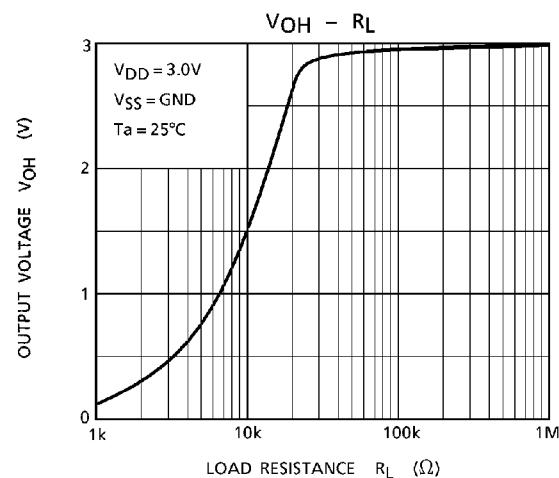
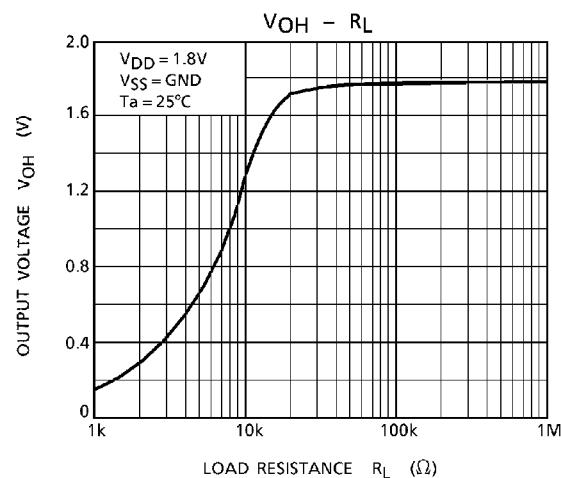
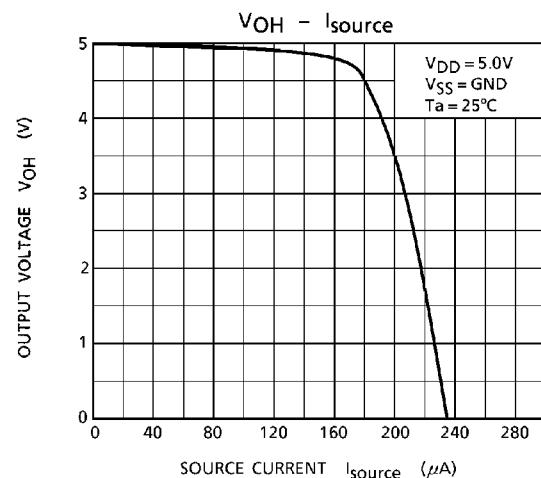
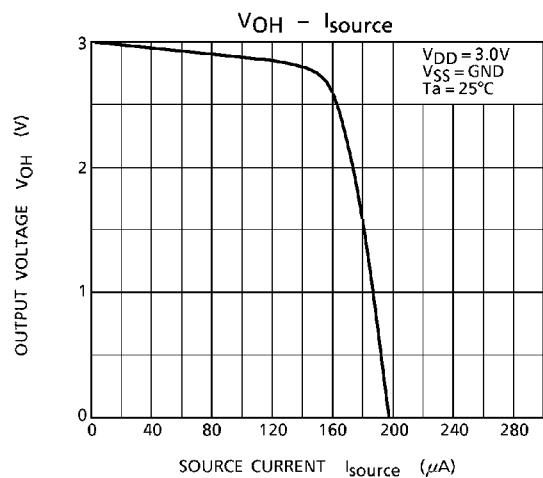
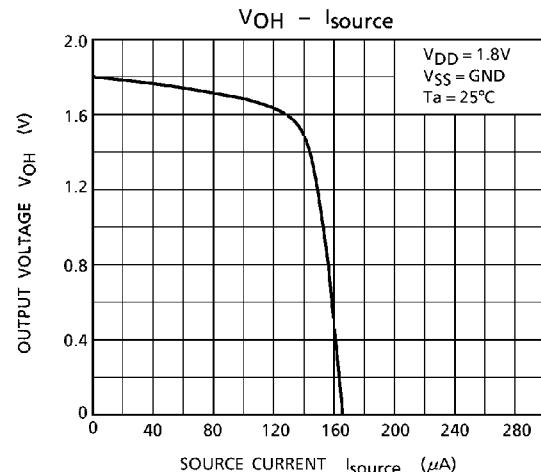
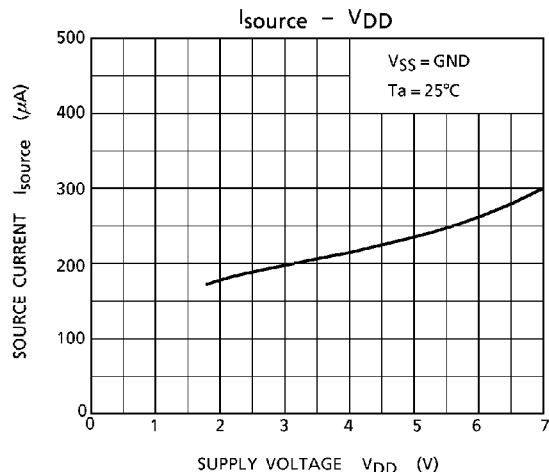
4.  $V_{OL}$ •  $V_{OL}$ 

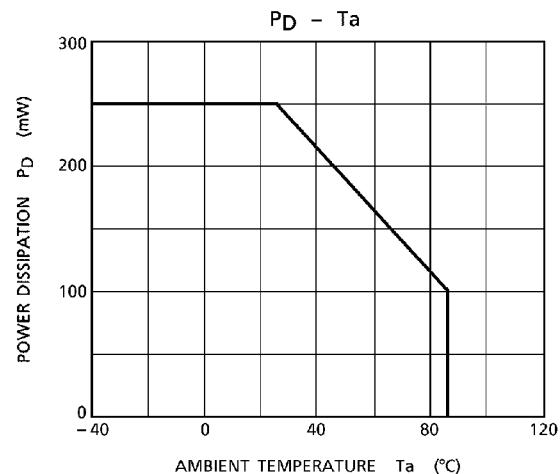
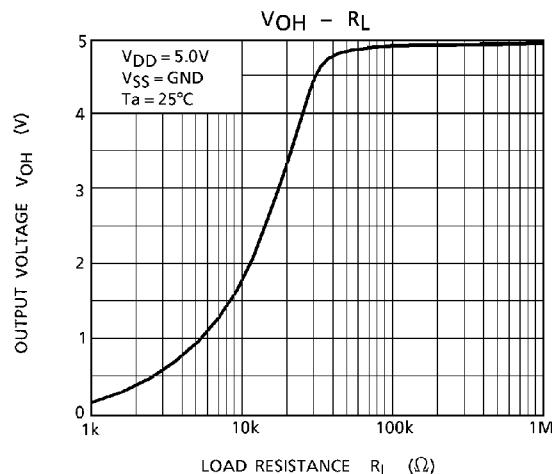
$$V_{IN1} = \frac{V_{DD}}{2} + 0.05V$$

$$V_{IN2} = \frac{V_{DD}}{2} - 0.05V$$

5.  $I_{DD}$ 6.  $I_{source}$ 7.  $I_{sink}$ 

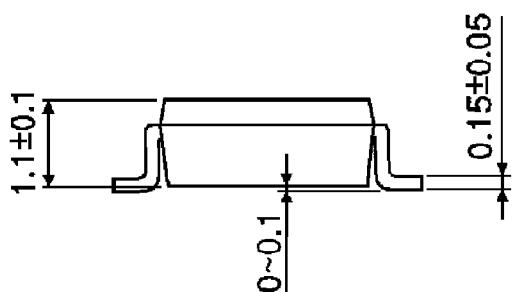
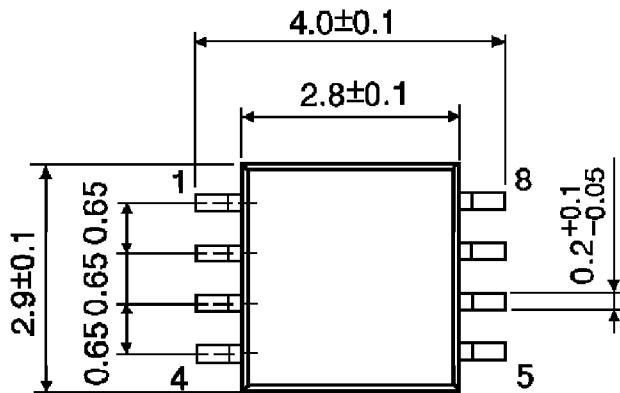






**OUTLINE DRAWING**  
SSOP8-P-0.65

Unit : mm



Weight : 0.021g (Typ.)